

Power MOSFET

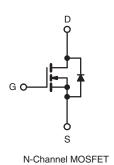
PRODUCT SUMMARY					
V _{DS} (V)	750				
$R_{DS(on)}(\Omega)$	V _{GS} = 10 V	1.7			
Q _g (Max.) (nC)	130				
Q _{gs} (nC)	17				
Q _{gd} (nC)	72				
Configuration	Single				

FEATURES

- Dynamic dV/dt rating
- Repetitive avalanche rated
- Isolated central mounting hole
- · Fast switching
- Ease of paralleling
- Simple drive requirements







ABSOLUTE MAXIMUM RATINGS (T _C = 25 °C, unless otherwise noted)						
PARAMETER			SYMBOL	LIMIT	UNIT	
Drain-Source Voltage			V_{DS}	750	V	
Gate-Source Voltage			V_{GS}	± 20		
Continuous Drain Current	V _{GS} at 10 V	T _C = 25 °C	- I _D	6.0		
		T _C = 100 °C		4.2	Α	
Pulsed Drain Current a			I _{DM}	24		
Linear Derating Factor				1.2	W/°C	
Single Pulse Avalanche Energy b			E _{AS}	490	mJ	
Repetitive Avalanche Current ^a			I _{AR}	5.4	Α	
Repetitive Avalanche Energy a			E _{AR}	15	mJ	
Maximum Power Dissipation	T _C = 25 °C		P_{D}	150	W	
Peak Diode Recovery dV/dt ^c			dV/dt	2.0	V/ns	
Operating Junction and Storage Temperature Range			T _J , T _{stg}	-55 to +150	°C	
Soldering Recommendations (Peak Temperature) ^d	for 10 s			300	7	
Mounting Toyour	6-32 or M3 screw			10	lbf ⋅ in	
Mounting Torque				1.1	N⋅m	

- a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11). b. $V_{DD}=50~V$, starting $T_J=25~^{\circ}C$, L=31~mH, $R_g=25~\Omega$, $I_{AS}=5.4~A$ (see fig. 12). c. $I_{SD}\leq 5.4~A$, $dI/dt\leq 120~A/\mu s$, $V_{DD}\leq 600$, $T_J\leq 150~^{\circ}C$.

- d. 1.6 mm from case.

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THERMAL RESISTANCE RATINGS						
PARAMETER	SYMBOL	TYP.	MAX.	UNIT		
Maximum Junction-to-Ambient	R _{thJA}	=	40			
Case-to-Sink, Flat, Greased Surface	R _{thCS}	0.24	-	°C/W		
Maximum Junction-to-Case (Drain)	R _{thJC}	-	0.83			

PARAMETER	SYMBOL	TEST CONDITIONS		MIN.	TYP.	MAX.	UNIT
Static					ļ.	ļ	
Drain-Source Breakdown Voltage	V _{DS}	$V_{GS} = 0$	$V_{GS} = 0 \text{ V}, I_{D} = 250 \mu\text{A}$		-	-	V
V _{DS} Temperature Coefficient	$\Delta V_{DS}/T_{J}$	Reference t	to 25 °C, I _D = 1 mA	-	0.98	-	V/°C
Gate-Source Threshold Voltage	V _{GS(th)}	$V_{DS} = V$	' _{GS} , I _D = 250 μA	2.0	-	4.0	V
Gate-Source Leakage	I _{GSS}	V _G	_S = ± 20 V	-	-	± 100	nA
Zero Gate Voltage Drain Current	I _{DSS}		00 V, V _{GS} = 0 V V _{GS} = 0 V, T _J = 125 °C	-	-	100 500	μΑ
Drain-Source On-State Resistance	R _{DS(on)}	V _{GS} = 10 V	I _D = 3.2 A ^b	-	1.7	-	Ω
Forward Transconductance	9 _{fs}		00 V, I _D = 3.2 A ^b	3.0		-	S
Dynamic		_			L		
Input Capacitance	C _{iss}	V	_{GS} = 0 V,	-	1900	-	
Output Capacitance	C _{oss}		$_{OS} = 25 \text{ V},$	-	470	-	pF
Reverse Transfer Capacitance	C _{rss}	f = 1.0	MHz, see fig. 5	-	280	-	
Total Gate Charge	Qg				-	130	
Gate-Source Charge	Q_{gs}	V _{GS} = 10 V	$I_D = 5.4 \text{ A}, V_{DS} = 400 \text{ V},$ see fig. 6 and 13 b	-	-	17	nC
Gate-Drain Charge	Q _{gd}	1	See lig. 0 and 15	-	-	72	
Turn-On Delay Time	t _{d(on)}				16	-	- ns
Rise Time	t _r	$V_{DD} = 400 \text{ V, } I_D = 5.4 \text{ A,}$ $R_g = 9.1 \ \Omega, \ R_D = 75 \ \Omega, \text{ see fig. } 10^{\text{ b}}$		-	36	-	
Turn-Off Delay Time	t _{d(off)}			-	100	-	
Fall Time	t _f			-	32	-	
Internal Drain Inductance	L _D	Between lead, 6 mm (0.25") from package and center of die contact		-	5.0	-	
Internal Source Inductance	L _S			-	13	-	nH
Drain-Source Body Diode Characteristic	s						
Continuous Source-Drain Diode Current	I _S	MOSFET symbol showing the integral reverse p - n junction diode		ı	-	5.4	A
Pulsed Diode Forward Current ^a	I _{SM}			-	-	22	_ ^
Body Diode Voltage	V _{SD}	T _J = 25 °C, I _S	_S = 5.4 A, V _{GS} = 0 V ^b	-	-	1.8	V
Body Diode Reverse Recovery Time	t _{rr}	T _J = 25 °C, I _F = 5.4 A, dl/dt = 100 A/μs b		-	550	830	ns
Body Diode Reverse Recovery Charge	Q _{rr}			-	2.4	3.6	μC
Forward Turn-On Time	t _{on}	Intrinsic turn-on time is negligible (turn-on is dominated by L _S and L _D)					L _D)

Notes

- a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).
- b. Pulse width $\leq 300~\mu s;$ duty cycle $\leq 2~\%.$



TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)

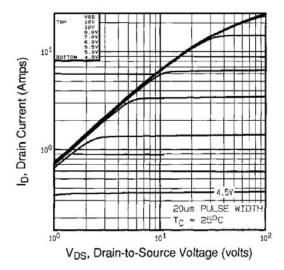


Fig. 1 - Typical Output Characteristics, T_C = 25 °C

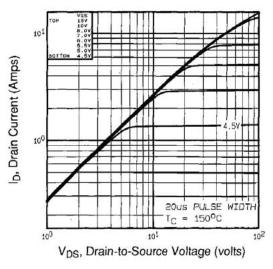


Fig. 2 - Typical Output Characteristics, T_C = 150 °C

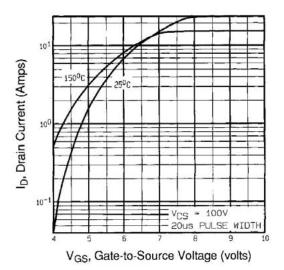


Fig. 3 - Typical Transfer Characteristics

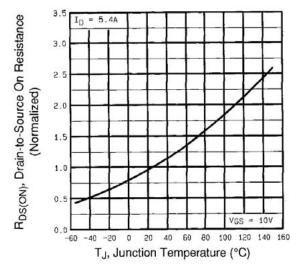


Fig. 4 - Normalized On-Resistance vs. Temperature



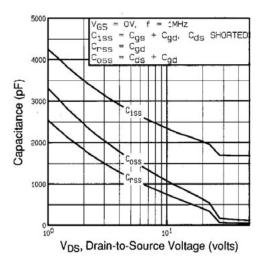


Fig. 5 - Typical Capacitance vs. Drain-to-Source Voltage

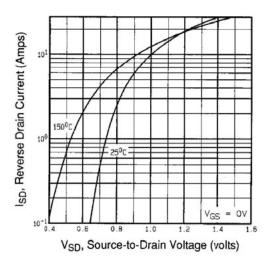


Fig. 7 - Typical Source-Drain Diode Forward Voltage

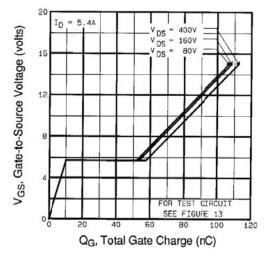


Fig. 6 - Typical Gate Charge vs. Gate-to-Source Voltage

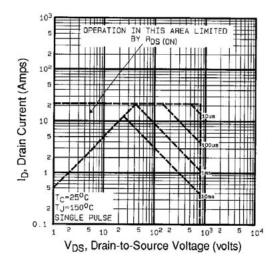


Fig. 8 - Maximum Safe Operating Area



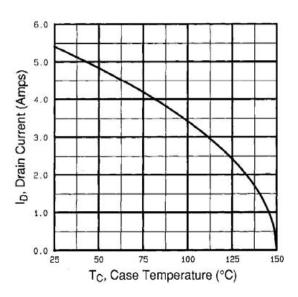


Fig. 9 - Maximum Drain Current vs. Case Temperature

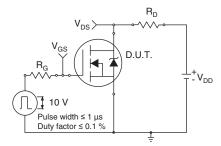


Fig. 10a - Switching Time Test Circuit

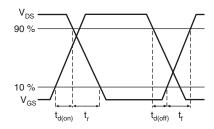


Fig. 10b - Switching Time Waveforms

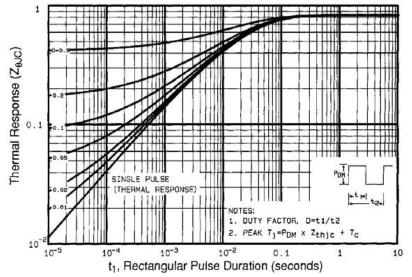
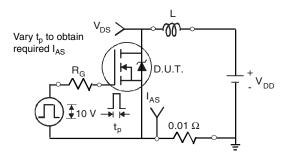
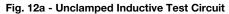


Fig. 11 - Maximum Effective Transient Thermal Impedance, Junction-to-Case







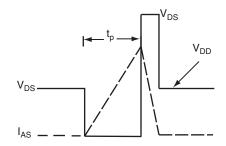


Fig. 12b - Unclamped Inductive Waveforms

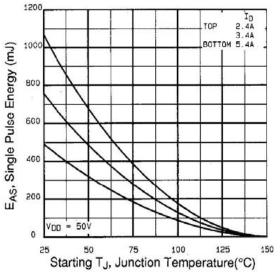


Fig. 12c - Maximum Avalanche Energy vs. Drain Current

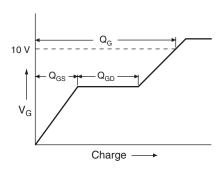


Fig. 13a - Basic Gate Charge Waveform

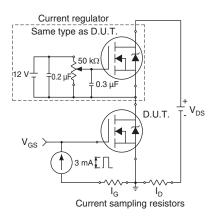
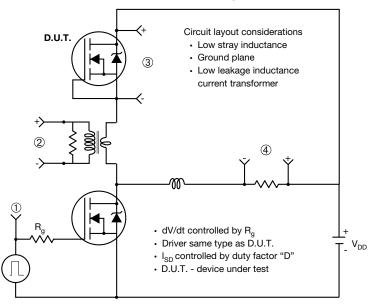


Fig. 13b - Gate Charge Test Circuit



Peak Diode Recovery dV/dt Test Circuit



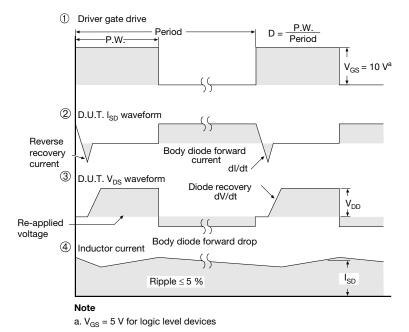
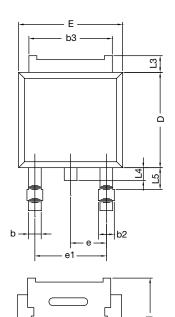


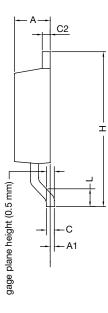
Fig. 14 - For N-Channel

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TO-252AA Case Outline





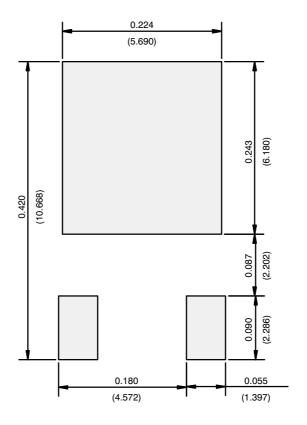
	MILLIN	METERS	INCHES		
DIM.	MIN.	MAX.	MIN.	MAX.	
Α	2.18	2.38	0.086	0.094	
A1	-	0.127	-	0.005	
b	0.64	0.88	0.025	0.035	
b2	0.76	1.14	0.030	0.045	
b3	4.95	5.46	0.195	0.215	
С	0.46	0.61	0.018	0.024	
C2	0.46	0.89	0.018	0.035	
D	5.97	6.22	0.235	0.245	
D1	4.10	-	0.161	-	
Е	6.35	6.73	0.250	0.265	
E1	4.32	-	0.170	-	
Н	9.40	10.41	0.370	0.410	
е	2.28	BSC	0.090 BSC		
e1	4.56	BSC	0.180 BSC		
L	1.40	1.78	0.055	0.070	
L3	0.89	1.27	0.035	0.050	
L4	-	1.02	-	0.040	
L5	1.01	1.52	0.040	0.060	
ECN: T16-0236-Rev. P, 16-May-16 DWG: 5347					

Notes

• Dimension L3 is for reference only.



RECOMMENDED MINIMUM PADS FOR DPAK (TO-252)



Recommended Minimum Pads Dimensions in Inches/(mm)

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